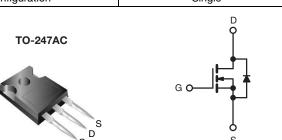


Vishay Siliconix

Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	50	500			
$R_{DS(on)}(\Omega)$	V _{GS} = 10 V	0.15			
Q _g (Max.) (nC)	210	210			
Q _{gs} (nC)	58	58			
Q _{gd} (nC)	10	100			
Configuration	Single				



N-Channel MOSFET

FEATURES

• Super Fast Body Diode Eliminates the Need for External Diodes in ZVS Applications



• Lower Gate Charge Results in Simpler Drive RoHS Requirements

- Enhanced dV/dt Capabilities Offer Improved Ruggedness
- Higher Gate Voltage Threshold Offers Improved Noise Immunity
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

- Zero Voltage Switching SMPS
- Telecom and Server Power Supplies
- Uninterruptible Power Supplies
- Motor Control Applications

ORDERING INFORMATION			
Package	TO-247AC		
Lead (Pb)-free	IRFP31N50LPbF		
Lead (FD)-life	SiHFP31N50L-E3		
SnPb	IRFP31N50L		
SIFD	SiHFP31N50L		

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)					
PARAMETER			SYMBOL	LIMIT	UNIT
Drain-Source Voltage			V _{DS}	500	V
Gate-Source Voltage			V_{GS}	± 30	7 °
Continuous Drain Current	V _{GS} at 10 V	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$		31	
Continuous Drain Current	VGS at 10 V	T _C = 100 °C	I _D	20	A
Pulsed Drain Current ^a			I _{DM}	124	
Linear Derating Factor				3.7	W/°C
Single Pulse Avalanche Energy ^b			E _{AS}	460	mJ
Repetitive Avalanche Current ^a			I _{AR}	31	А
Repetitive Avalanche Energy ^a			E _{AR}	46	mJ
Maximum Power Dissipation $T_C = 25 ^{\circ}C$			P_{D}	460	W
Peak Diode Recovery dV/dt ^c			dV/dt	19	V/ns
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	°C
Soldering Recommendations (Peak Temperature) for 10 s				300 ^d	7
Mounting Toyour	6.20.0*	0.00 140		10	lbf ⋅ in
Mounting Torque	6-32 or M3 screw			1.1	N⋅m

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Starting T_J = 25 °C, L = 1 mH, R_g = 25 Ω , I_{AS} = 31 A (see fig. 12).
- c. $I_{SD} \leq 31$ A, $dI/dt \leq 422$ A/µs, $V_{DD} \leq V_{DS},\, T_{J} \leq 150$ °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRFP31N50L, SiHFP31N50L

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THERMAL RESISTANCE RATINGS					
PARAMETER SYMBOL TYP. MAX. UNIT					
Maximum Junction-to-Ambient	R _{thJA}	-	40		
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.24	-	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.26		

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	= 0 V, I _D = 250 μA	500	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C, I _D = 1 mA	-	0.28	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	· V _{GS} , I _D = 250 μA	3.0	-	5.0	V
Gate-Source Leakage	I _{GSS}	,	V _{GS} = ± 30 V	-	-	± 100	nA
Zana Onto Walliana Buria O annot		V _{DS} =	500 V, V _{GS} = 0 V	-	-	50	μΑ
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 400 V	, V _{GS} = 0 V, T _J = 125 °C	-	-	2.0	mA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 19 A ^b	-	0.15	0.18	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	= 50 V, I _D = 19 A ^b	15	-	-	S
Dynamic							
Input Capacitance	C _{iss}		V _{GS} = 0 V,	-	5000	-	
Output Capacitance	C _{oss}		$V_{DS} = 25 \text{ V},$	-	553	-	
Reverse Transfer Capacitance	C _{rss}	f = 1.	0 MHz, see fig. 5	-	59	-	
Outrat Constitutes	0		V _{DS} = 1.0 V , f = 1.0 MHz		6630	-	pF
Output Capacitance	C_{oss}	.,	V _{DS} = 400 V , f = 1.0 MHz	-	155	-	-
Effective Output Capacitance	C _{oss} eff.	$V_{GS} = 0 V$	V _{GS} = 0 V		276	-	1
Effective Output Capacitance	Coss eff. (ER)	1	$V_{DS} = 0 \text{ V to } 400 \text{ V}^{c}$	-	200	-	1
Total Gate Charge	Qg			-	-	210	
Gate-Source Charge	Q _{gs}	$V_{GS} = 10 \text{ V}$ $I_D = 31 \text{ A}, V_{DS} = 400 \text{ V},$ see fig. 7 and 13^b		-	-	58	nC
Gate-Drain Charge	Q _{gd}	1	see lig. 7 and 10	-	-	100	1
Internal Gate Resistance	Rg	f = 1	f = 1 MHz, open drain		1.1	-	Ω
Turn-On Delay Time	t _{d(on)}			-	28	-	
Rise Time	t _r	V _{DD} =	: 250 V, I _D = 31 A,	-	115	-	1
Turn-Off Delay Time	t _{d(off)}	$R_g = 4.3 \Omega$, see fig. 10^b		-	54	-	ns
Fall Time	t _f			-	53	-	1
Drain-Source Body Diode Characteristic	s				I.	•	
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the		-	-	31	A
Pulsed Diode Forward Current ^a	I _{SM}		integral reverse p - n junction diode		-	124	
Body Diode Voltage	V _{SD}	T _J = 25 °C, I _S = 31 A, V _{GS} = 0 V ^b		-	-	1.5	V
Pady Diada Payaraa Passyary Tim-	,	T _J = 25 °C, I _F = 31 A		-	170	250	
Body Diode Reverse Recovery Time	t _{rr}	T _J = 125 °C, dl/dt = 100 A/µs ^b		-	220	330	ns
Rady Diada Dayaraa Daaaaa Obaa		$T_J = 25 ^{\circ}\text{C}, I_S = 31 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	570	860	nC
Body Diode Reverse Recovery Charge	Q_{rr}	T _J = 125	°C, dl/dt = 100 A/µsb	-	1.2	1.8	μC
Reverse Recovery Current	I _{RRM}	T _J = 25 °C		-	7.9	12	Α
Forward Turn-On Time	t _{on}	Intrinsic tu	-on is do	minated b	y L _S and	L _D)	

- Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). Pulse width $\leq 300~\mu s$; duty cycle $\leq 2~\%$. Coss eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DS} . C_{oss} eff. (ER) is a fixed capacitance that stores the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DS} .



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

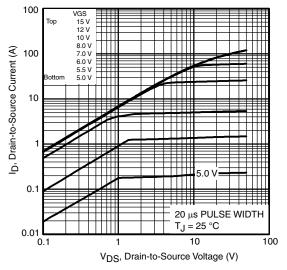


Fig. 1 - Typical Output Characteristics

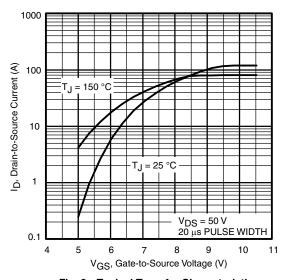


Fig. 3 - Typical Transfer Characteristics

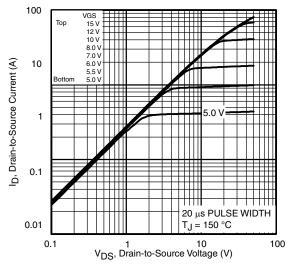


Fig. 2 - Typical Output Characteristics

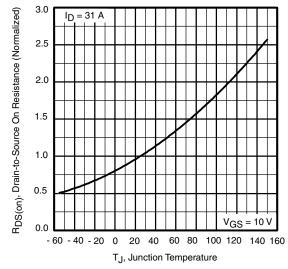


Fig. 4 - Normalized On-Resistance vs. Temperature

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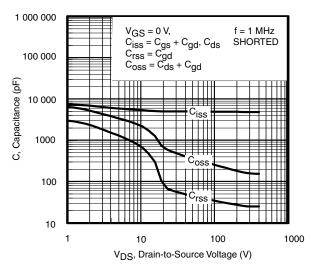


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

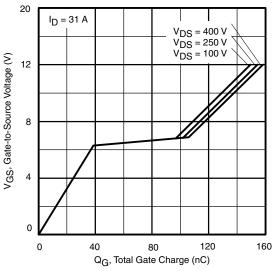


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

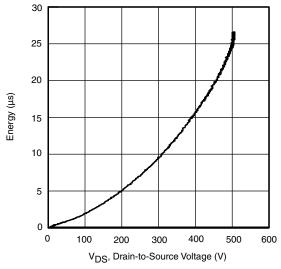


Fig. 6 - Output Capacitance Stored Energy vs. V_{DS}

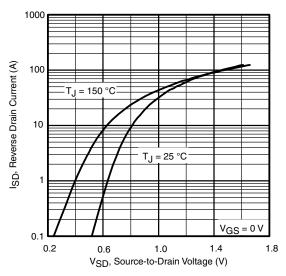


Fig. 8 - Typical Source Drain Diode Forward Voltage



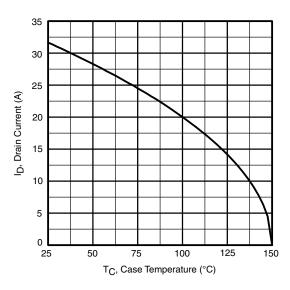


Fig. 9 - Maximum Drain Current vs. Case Temperature

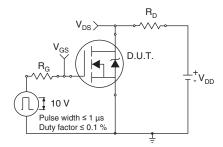


Fig. 10a - Switching Time Test Circuit

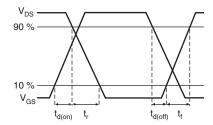


Fig. 10b - Switching Time Waveforms

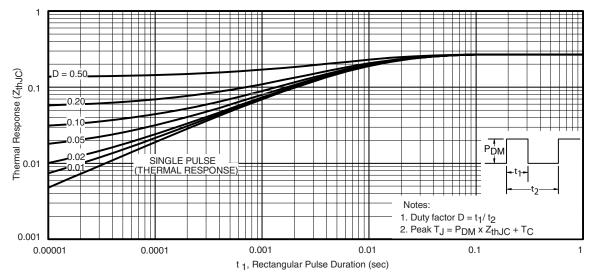


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

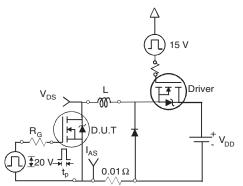


Fig. 12a - Unclamped Inductive Test Circuit

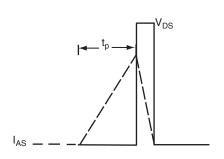


Fig. 12b - Unclamped Inductive Waveforms

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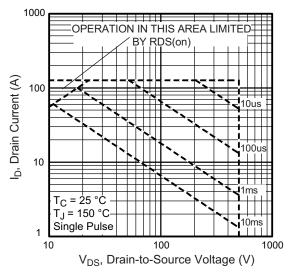
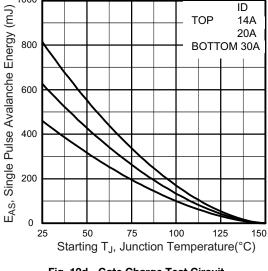


Fig. 12c - Maximum Avalanche Energy vs. Drain Current



1000

Fig. 12d - Gate Charge Test Circuit

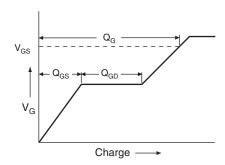


Fig. 13a - Maximum Safe Operating Area

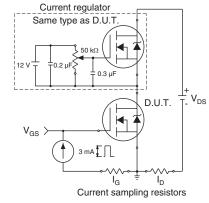
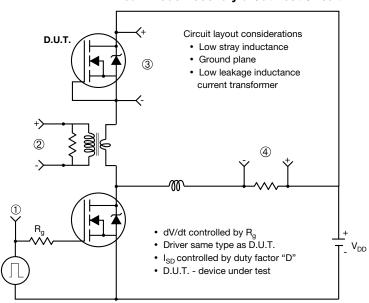


Fig. 13b - Basic Gate Charge Waveform



Peak Diode Recovery dV/dt Test Circuit



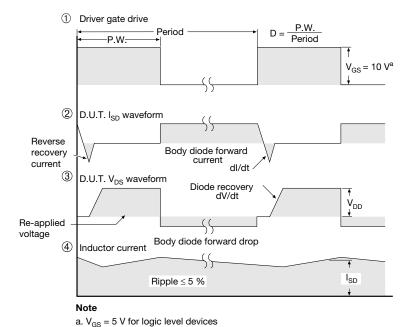


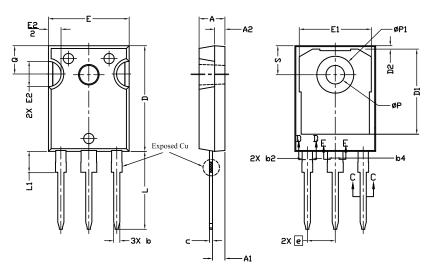
Fig. 14 - For N-Channel

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?91220.



TO-247AC (High Voltage)

VERSION 1: FACILITY CODE = 9







Section C--C,D--D,E--E

	MILLIN	IETERS	
DIM.	MIN.	MAX.	NOTES
Α	4.83	5.21	
A1	2.29	2.55	
A2	1.50	2.49	
b	1.12	1.33	
b1	1.12	1.28	
b2	1.91	2.39	6
b3	1.91	2.34	
b4	2.87	3.22	6, 8
b5	2.87	3.18	
С	0.55	0.69	6
c1	0.55	0.65	
D	20.40	20.70	4

	MILLIM		
DIM.	MIN.	MAX.	NOTES
D1	16.25	16.85	5
D2	0.56	0.76	
E	15.50	15.87	4
E1	13.46	14.16	5
E2	4.52	5.49	3
е	5.44	BSC	
L	14.90	15.40	
L1	3.96	4.16	6
ØΡ	3.56	3.65	7
Ø P1	7.19		
Q	5.31	5.69	
S	5.54	5.74	

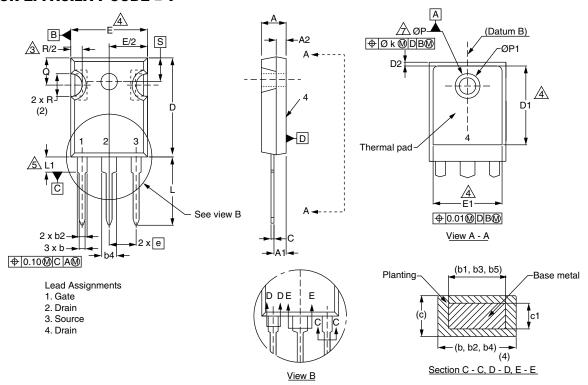
Notes

- (1) Package reference: JEDEC® TO247, variation AC
- (2) All dimensions are in mm
- (3) Slot required, notch may be rounded
- (4) Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm per side. These dimensions are measured at the outermost extremes of the plastic body
- (5) Thermal pad contour optional with dimensions D1 and E1
- (6) Lead finish uncontrolled in L1
- $^{(7)}$ Ø P to have a maximum draft angle of 1.5° to the top of the part with a maximum hole diameter of 3.91 mm
- (8) Dimension b2 and b4 does not include dambar protrusion. Allowable dambar protrusion shall be 0.1 mm total in excess of b2 and b4 dimension at maximum material condition

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VERSION 2: FACILITY CODE = Y



	MILLIN	IETERS	
DIM.	MIN.	MAX.	NOTES
Α	4.58	5.31	
A1	2.21	2.59	
A2	1.17	2.49	
b	0.99	1.40	
b1	0.99	1.35	
b2	1.53	2.39	
b3	1.65	2.37	
b4	2.42	3.43	
b5	2.59	3.38	
С	0.38	0.86	
c1	0.38	0.76	
D	19.71	20.82	
D1	13.08	-	

	MILLIN		
DIM.	MIN.	MAX.	NOTES
D2	0.51	1.30	
Е	15.29	15.87	
E1	13.72	-	
е	5.46	BSC	
Øk	0.2	254	
L	14.20	16.25	
L1	3.71	4.29	
ØР	3.51	3.66	
Ø P1	-	7.39	
Q	5.31	5.69	
R	4.52	5.49	
S	5.51 BSC		
	•		

Notes

DWG: 5971

- (1) Dimensioning and tolerancing per ASME Y14.5M-1994
- (2) Contour of slot optional
- (3) Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outermost extremes of the plastic body
- (4) Thermal pad contour optional with dimensions D1 and E1
- (5) Lead finish uncontrolled in L1

ECN: E19-0614-Rev. E, 08-Jan-2020

- (6) Ø P to have a maximum draft angle of 1.5 to the top of the part with a maximum hole diameter of 3.91 mm (0.154")
- (7) Outline conforms to JEDEC outline TO-247 with exception of dimension c



Legal Disclaimer Notice

Vishay

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